


<b>Search Notes</b> 	<b>Application/Control No.</b> 10554174	<b>Applicant(s)/Patent Under Reexamination</b> HAYAISHI, IKUO
	<b>Examiner</b> Phuoc Tran	<b>Art Unit</b> 2624

SEARCHED			
Class	Subclass	Date	Examiner
382	162, 165, 167, 274	6/16/08	PT
358	516, 518, 519, 520	6/16/08	PT
348	223.1	6/16/08	PT

SEARCH NOTES			
Search Notes		Date	Examiner
Inventorship Search		6/19/08	PT
Interference Search History Printout		6/19/08	PT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
PGPUB Text Search		6/19/08	PT